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**Lin et al.**

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(54) **PACKAGING AN ARCUATE PLANAR LIGHTWAVE CIRCUIT**

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See application file for complete search history.

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This patent is subject to a terminal disclaimer.

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“Packaging of Large-Scale Planar Lightwave Circuits”, by Kato et al., IEEE Transactions on Components, Packaging, and Manufacturing Technology, Part B, vol. 21, No. 2, pp. 121-129, 1996.

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*Primary Examiner* — Robert Tavlykaev

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**G02B 6/26** (2006.01)

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(57) **ABSTRACT**

A package for an arcuate planar lightwave circuit (PLC) chip includes a heater plate coupled to a base by a thick and soft support layer. The arcuate PLC is attached to the heater plate by soft adhesive. A hard adhesive is applied to a multi-waveguide end of the arcuate PLC, to additionally strengthen the attachment of the arcuate PLC to the heater plate. The structure allows the mechanical stress due to fiber pull/shock/vibration to be dissipated in the support layer without introducing large wavelength shifts in the arcuate PLC. The support layer also serves as a heat insulator, facilitating uniform heating of the arcuate PLC.

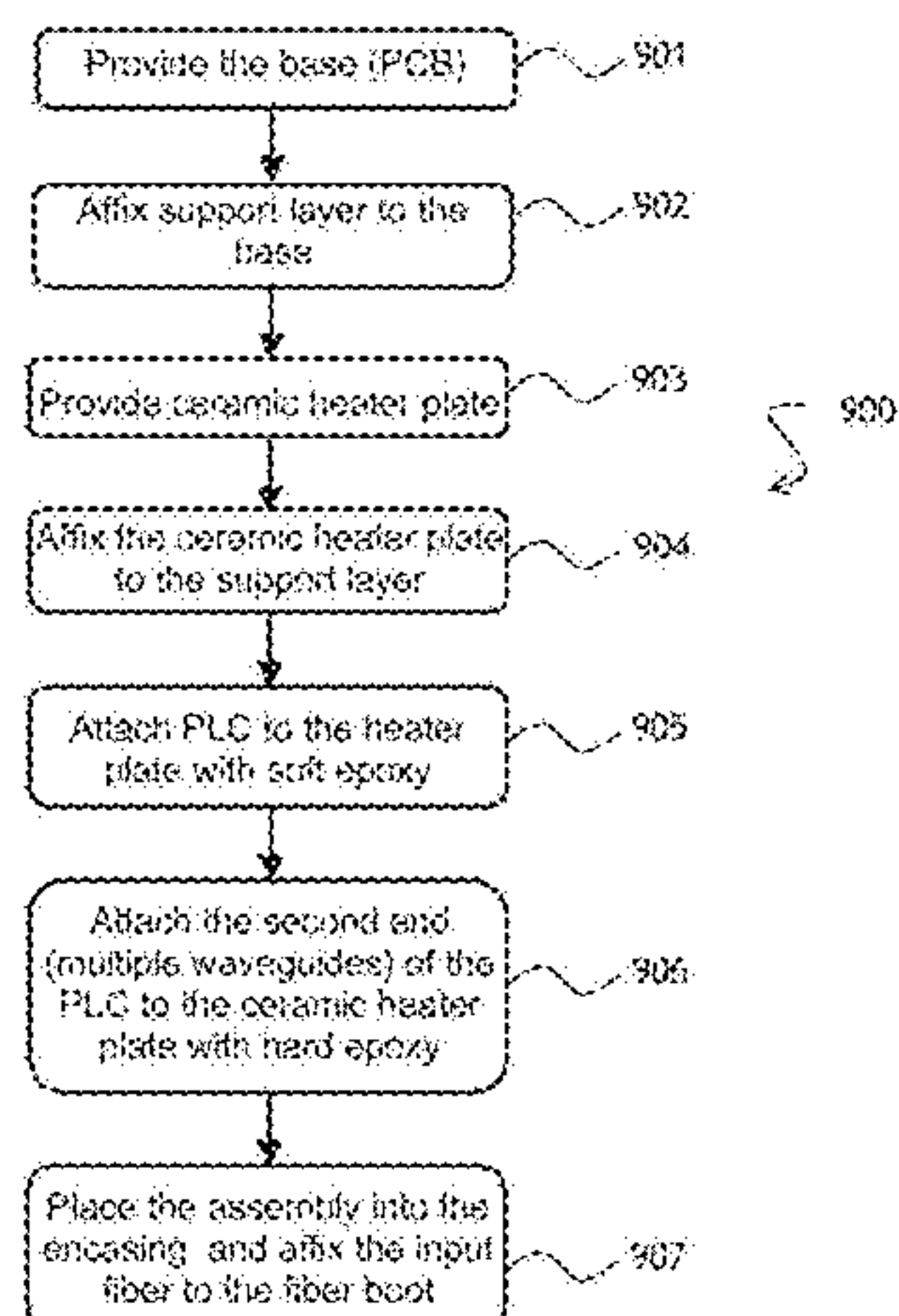
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**20 Claims, 10 Drawing Sheets**



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*G02B 6/02* (2006.01)  
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*6/2938* (2013.01); *G02B 6/424* (2013.01)

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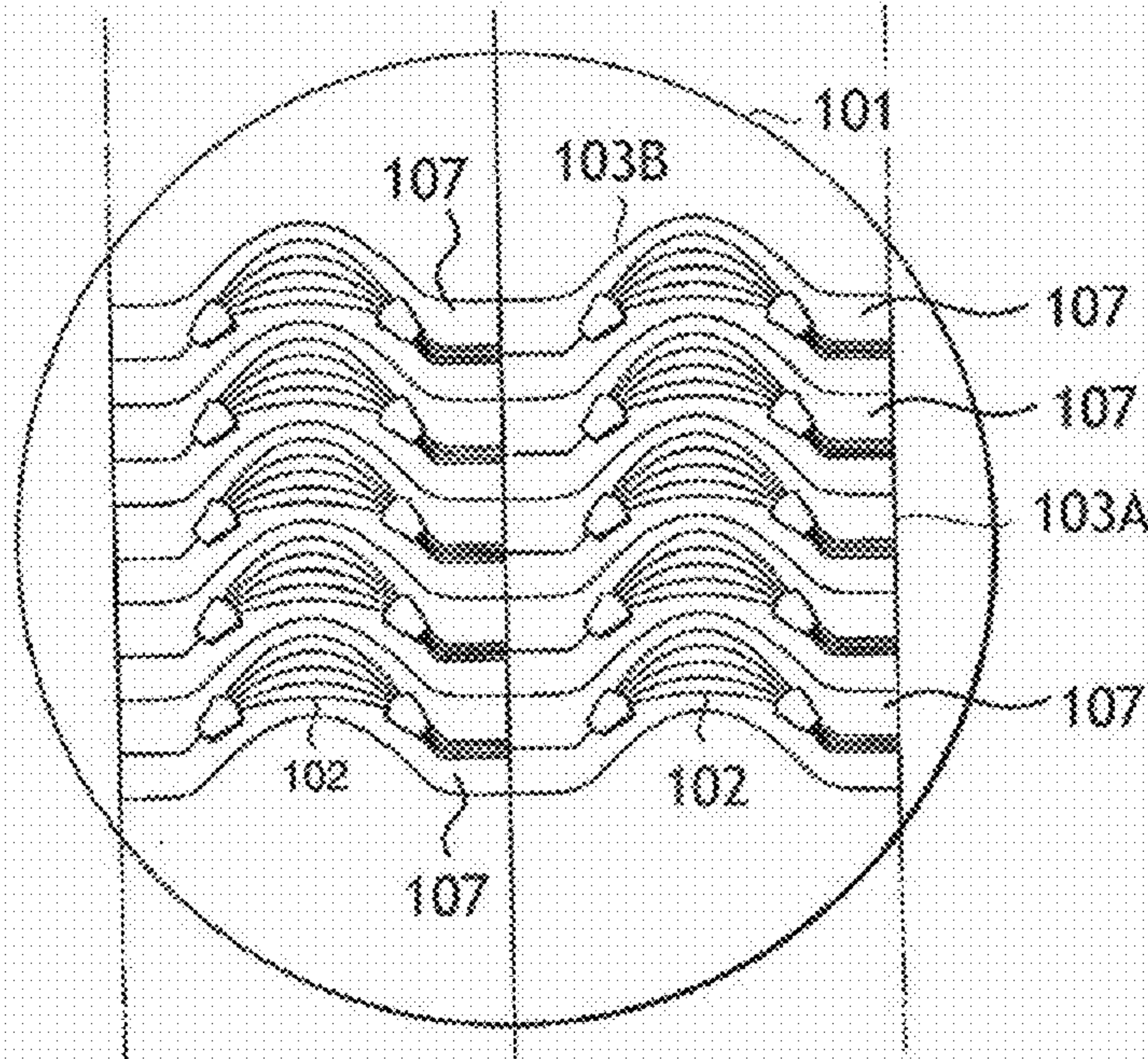
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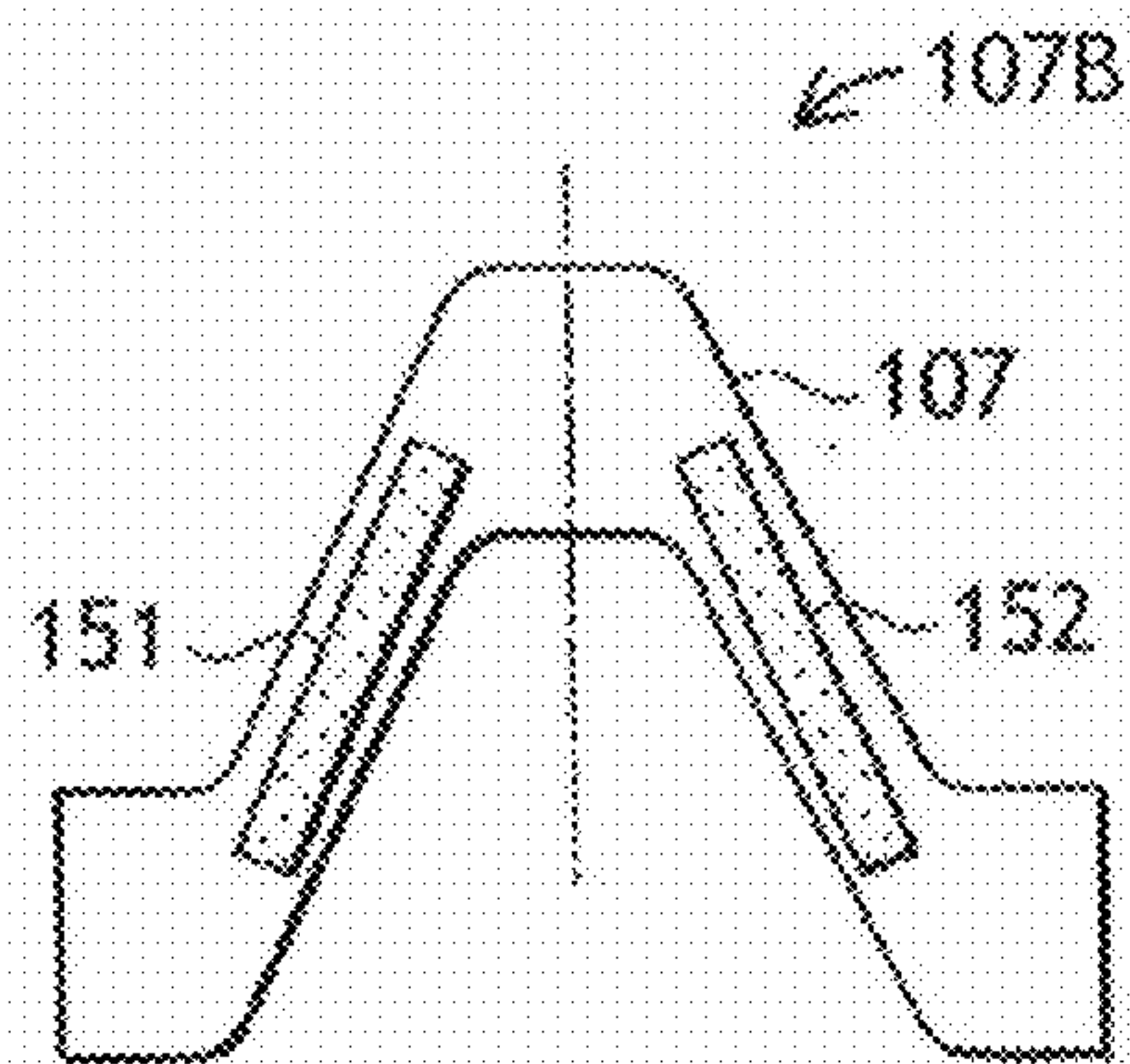
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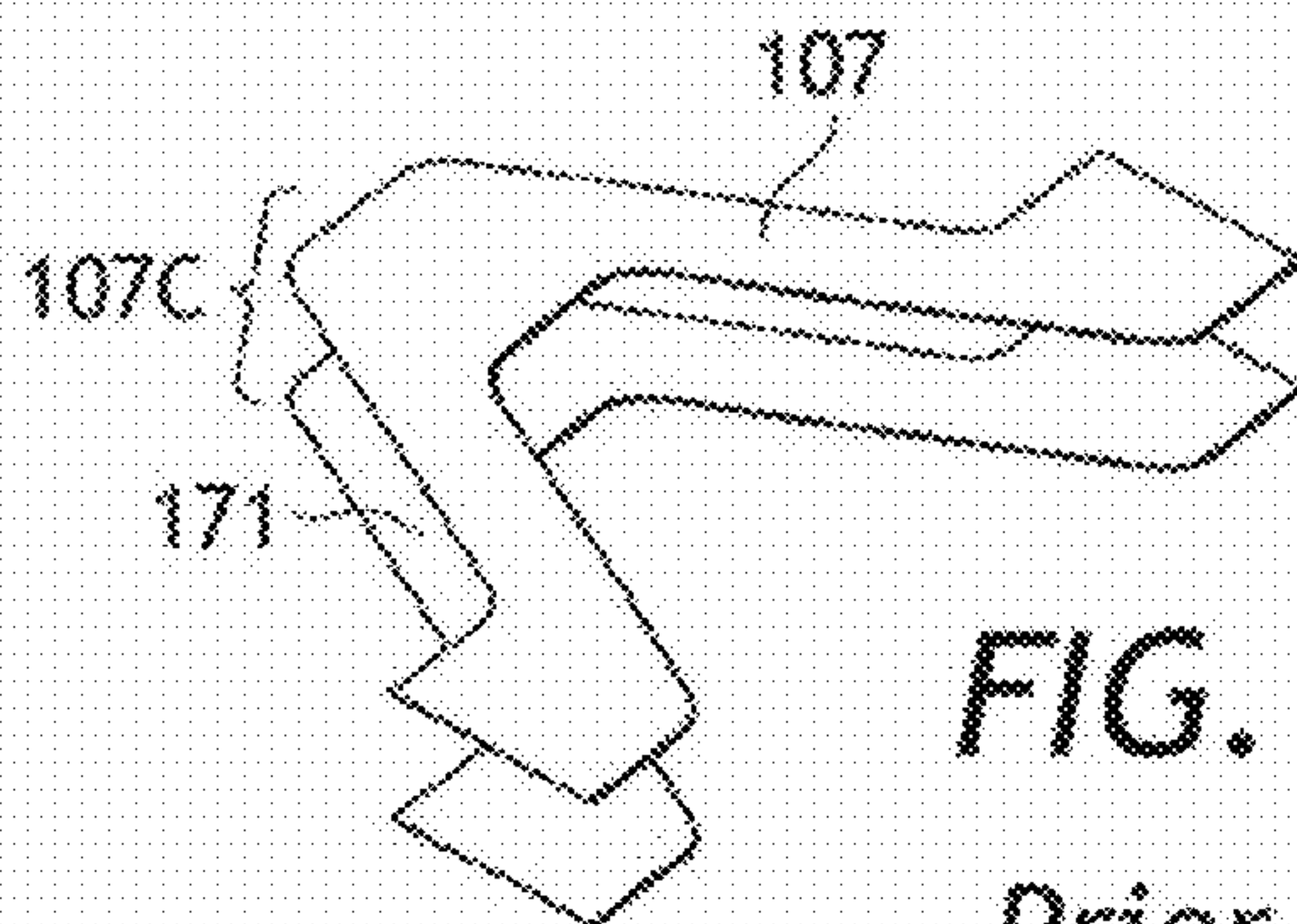




**FIG. 1A**  
*Prior Art*



**FIG. 1B**  
*Prior Art*



**FIG. 1C**  
*Prior Art*



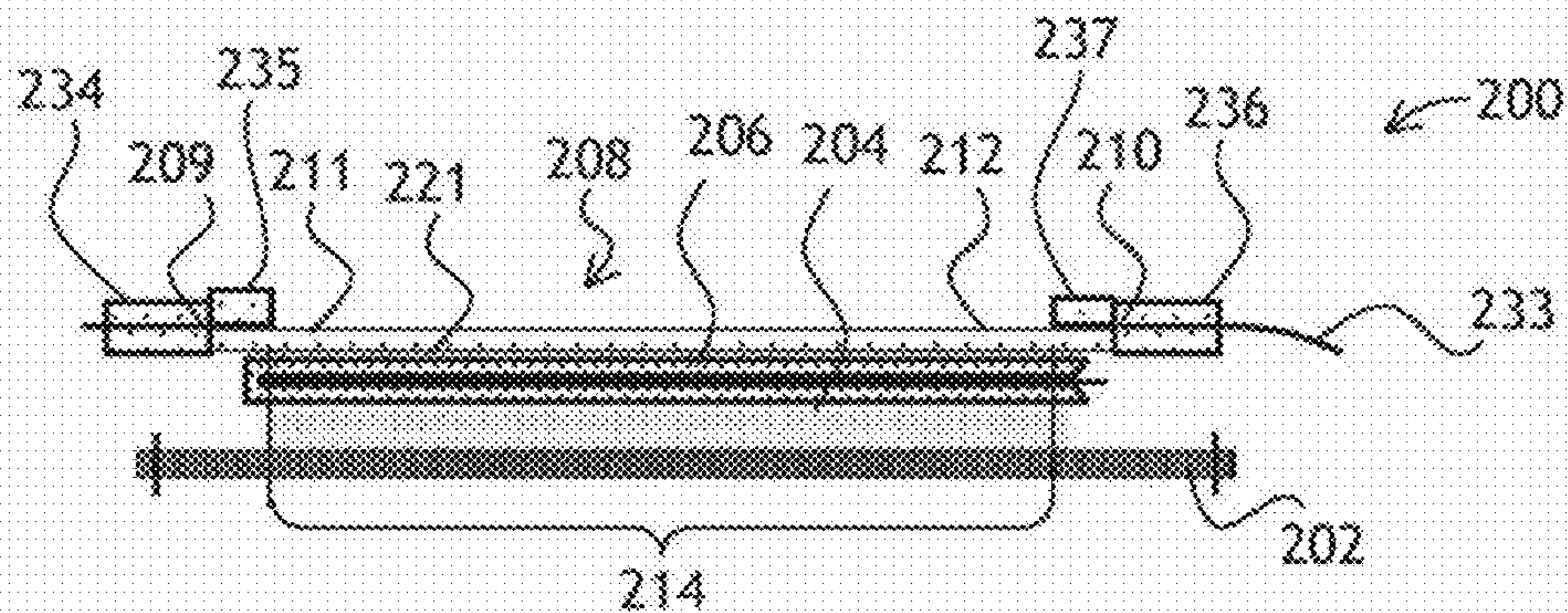


FIG. 2A

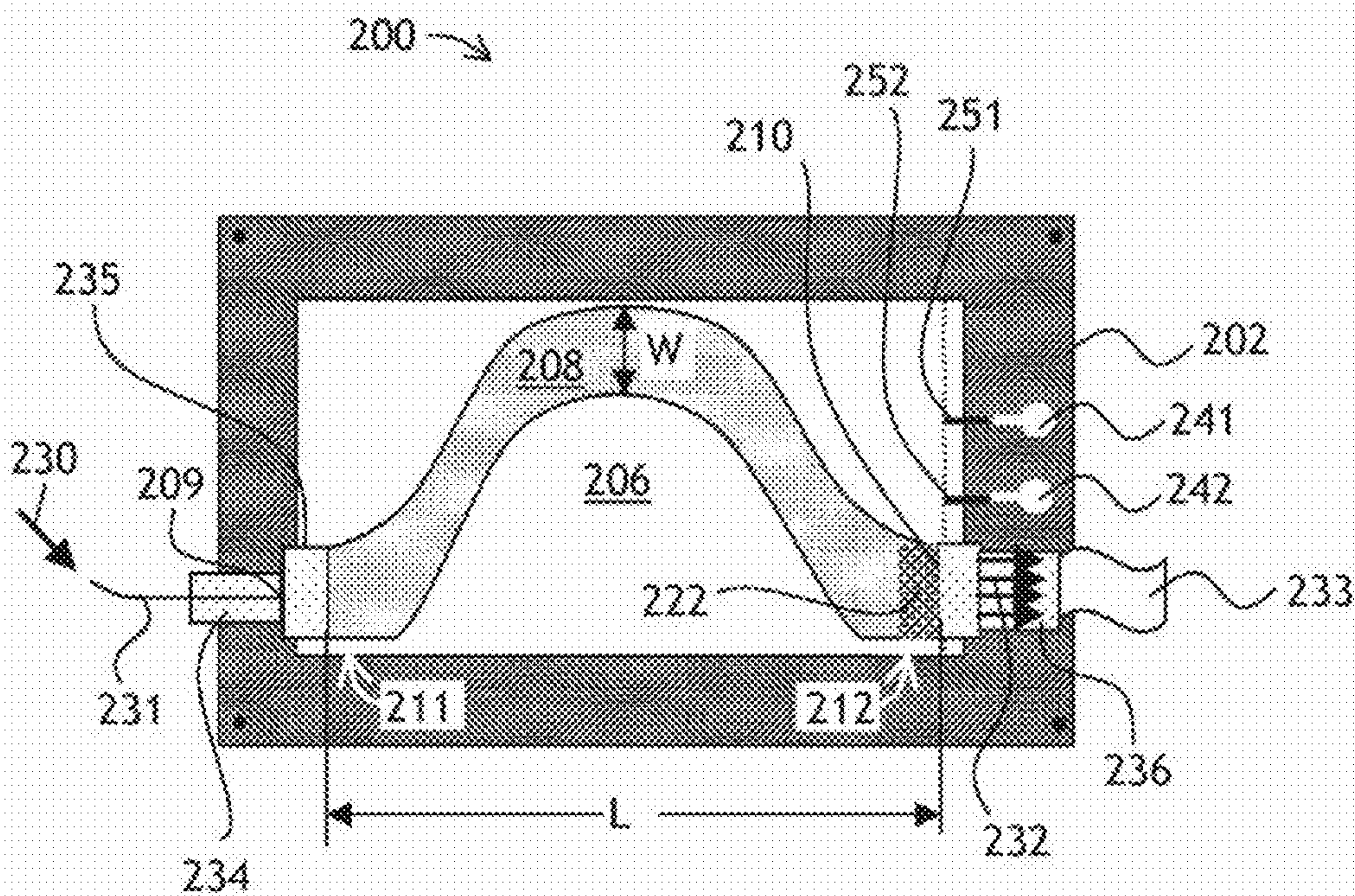


FIG. 2B



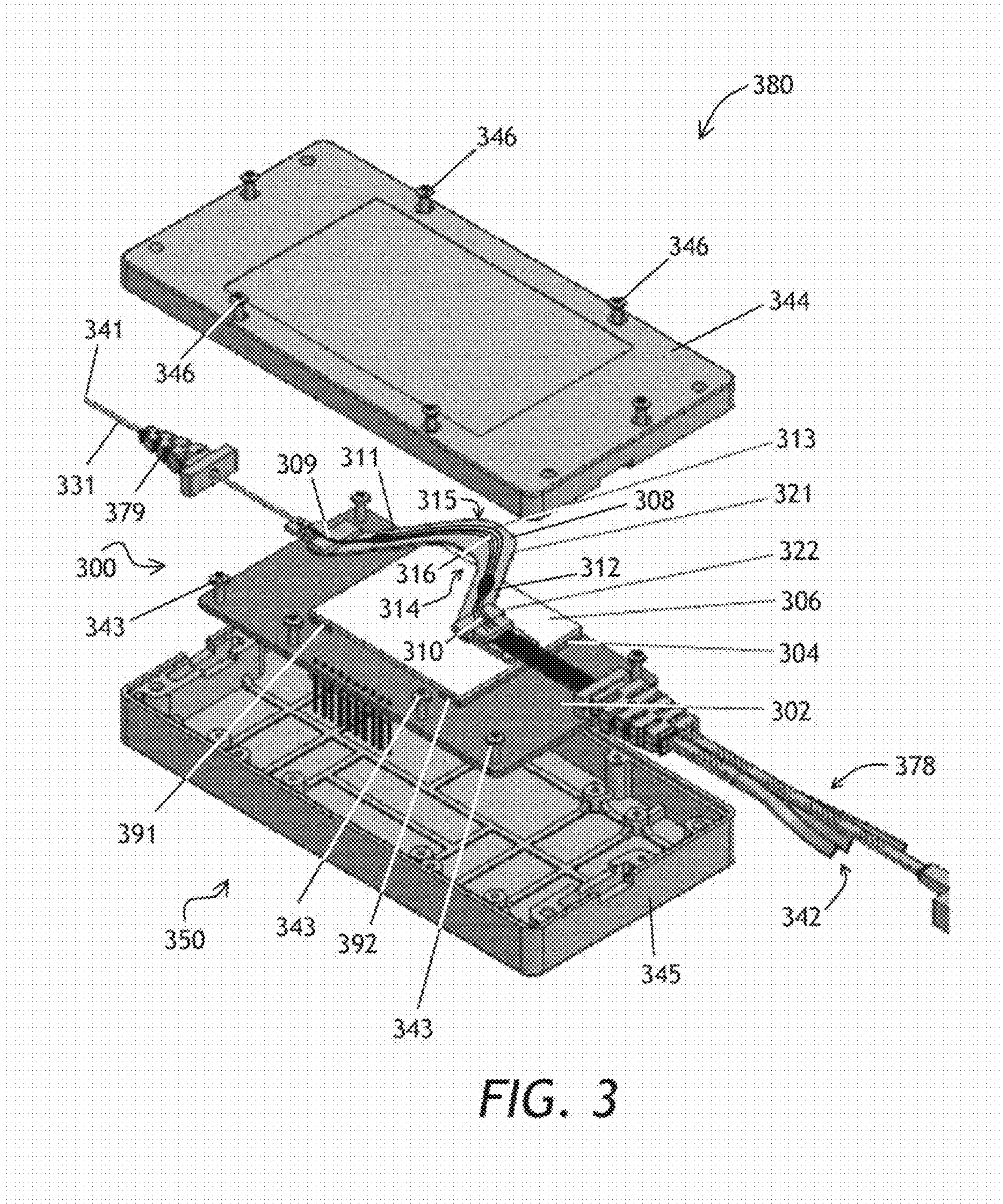
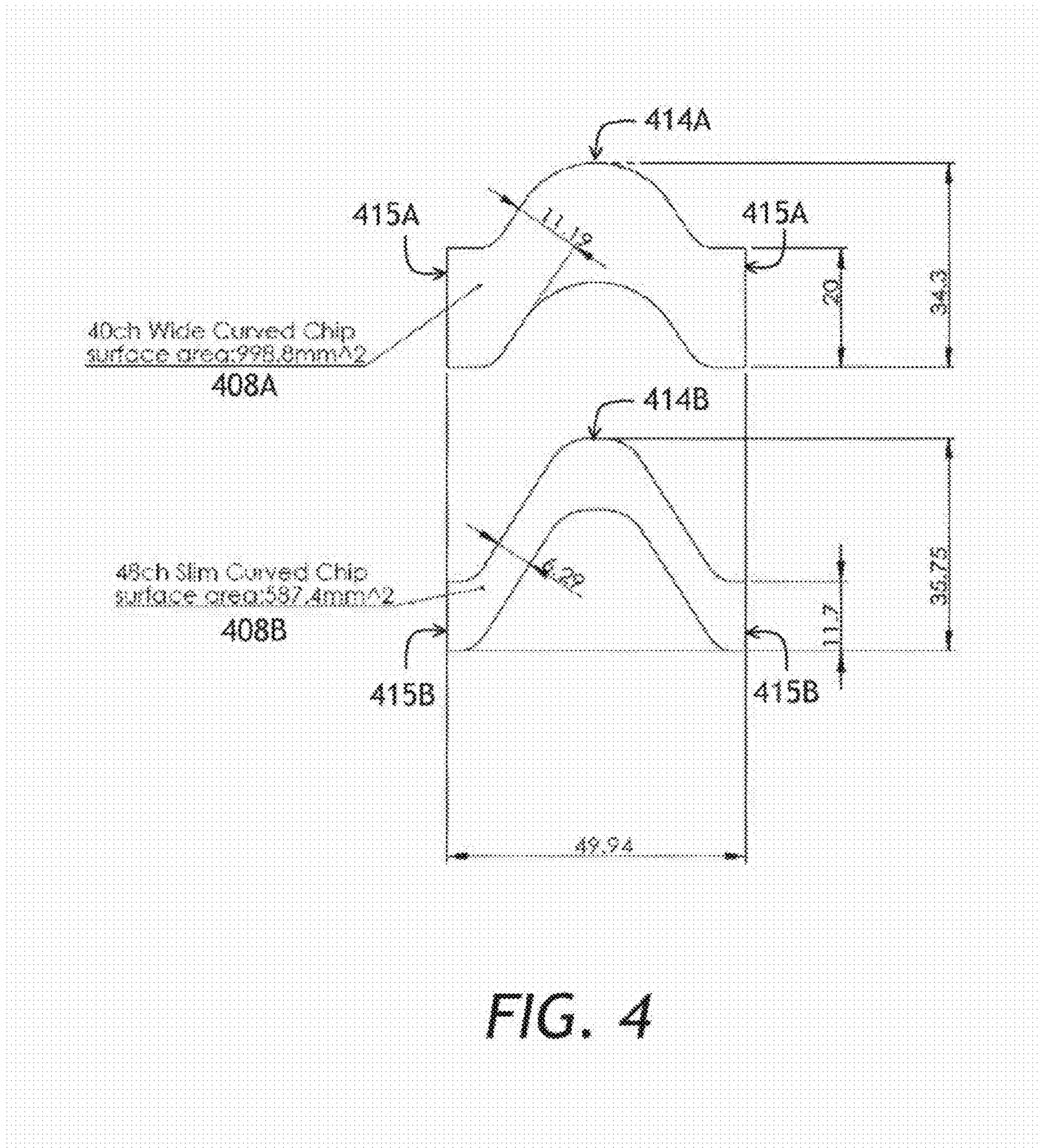


FIG. 3







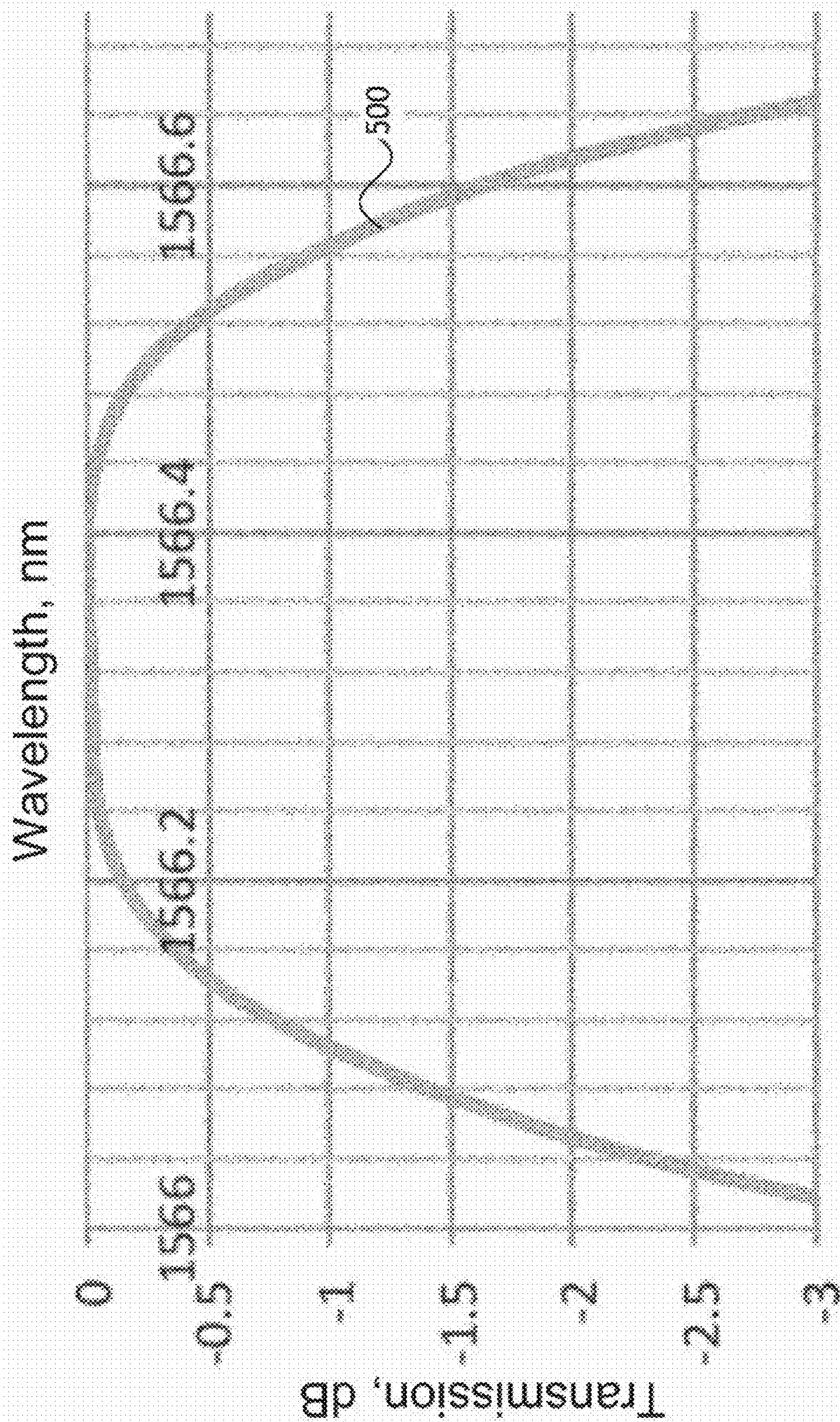


FIG. 5



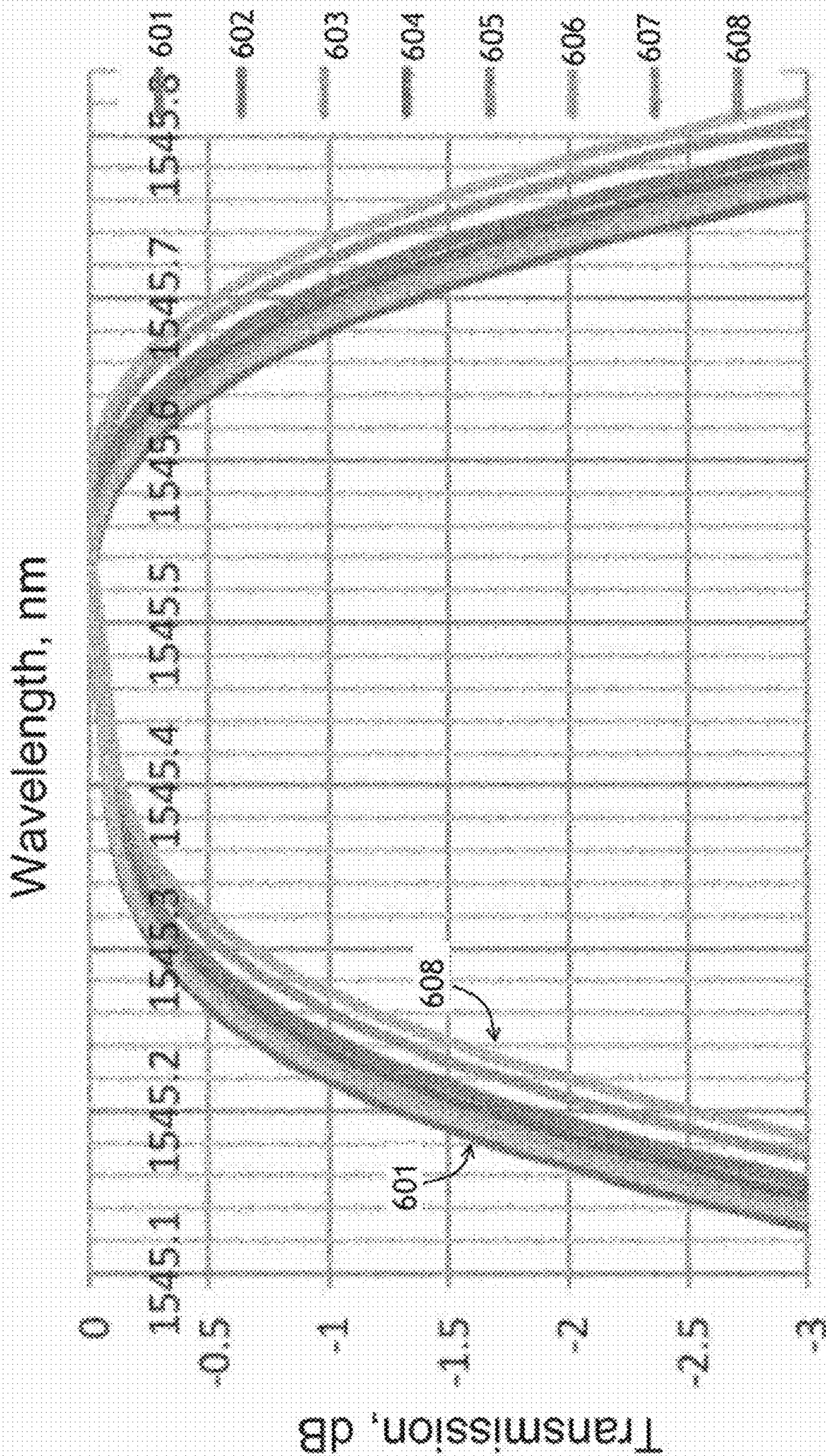


FIG. 6



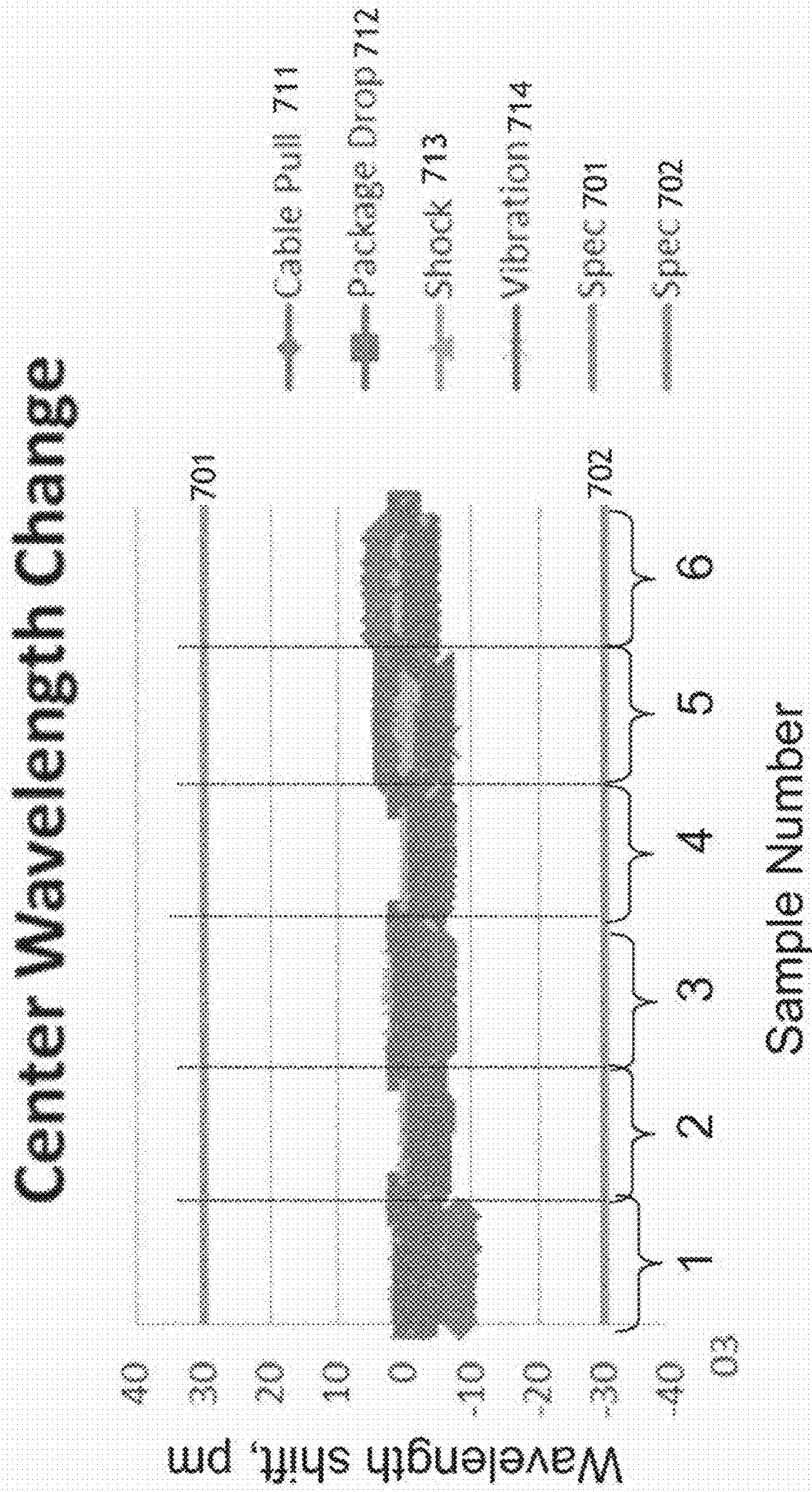
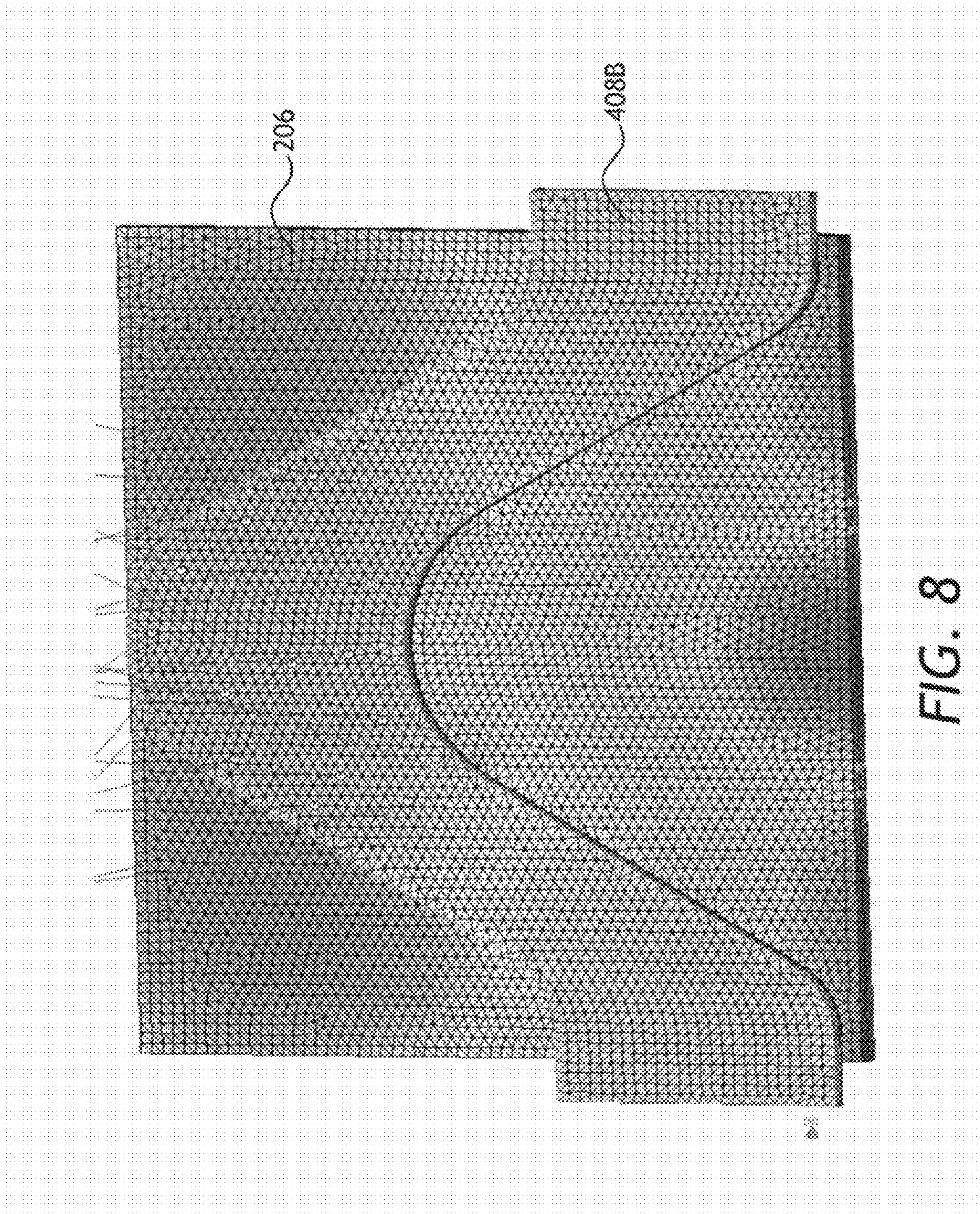


FIG. 7







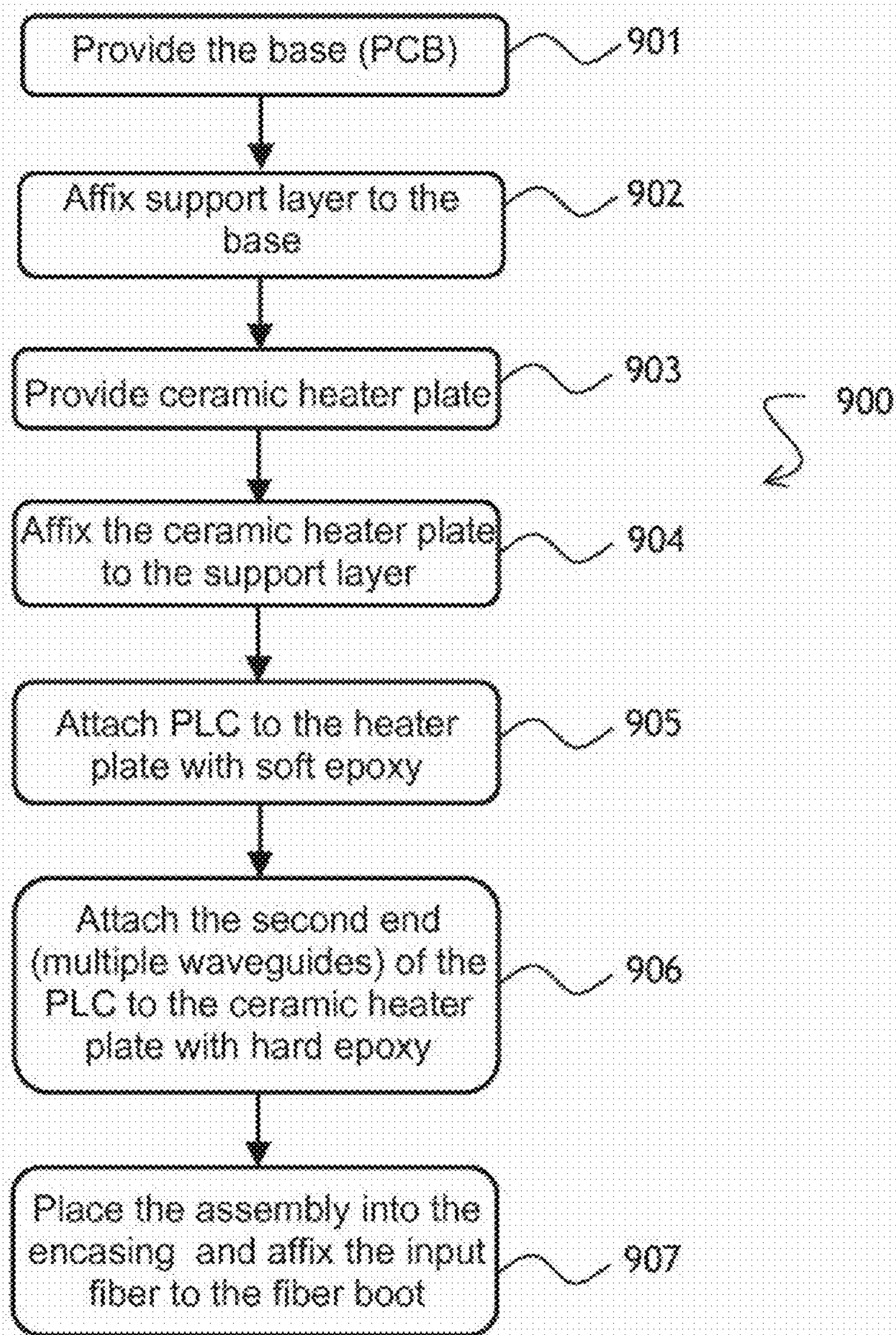


FIG. 9



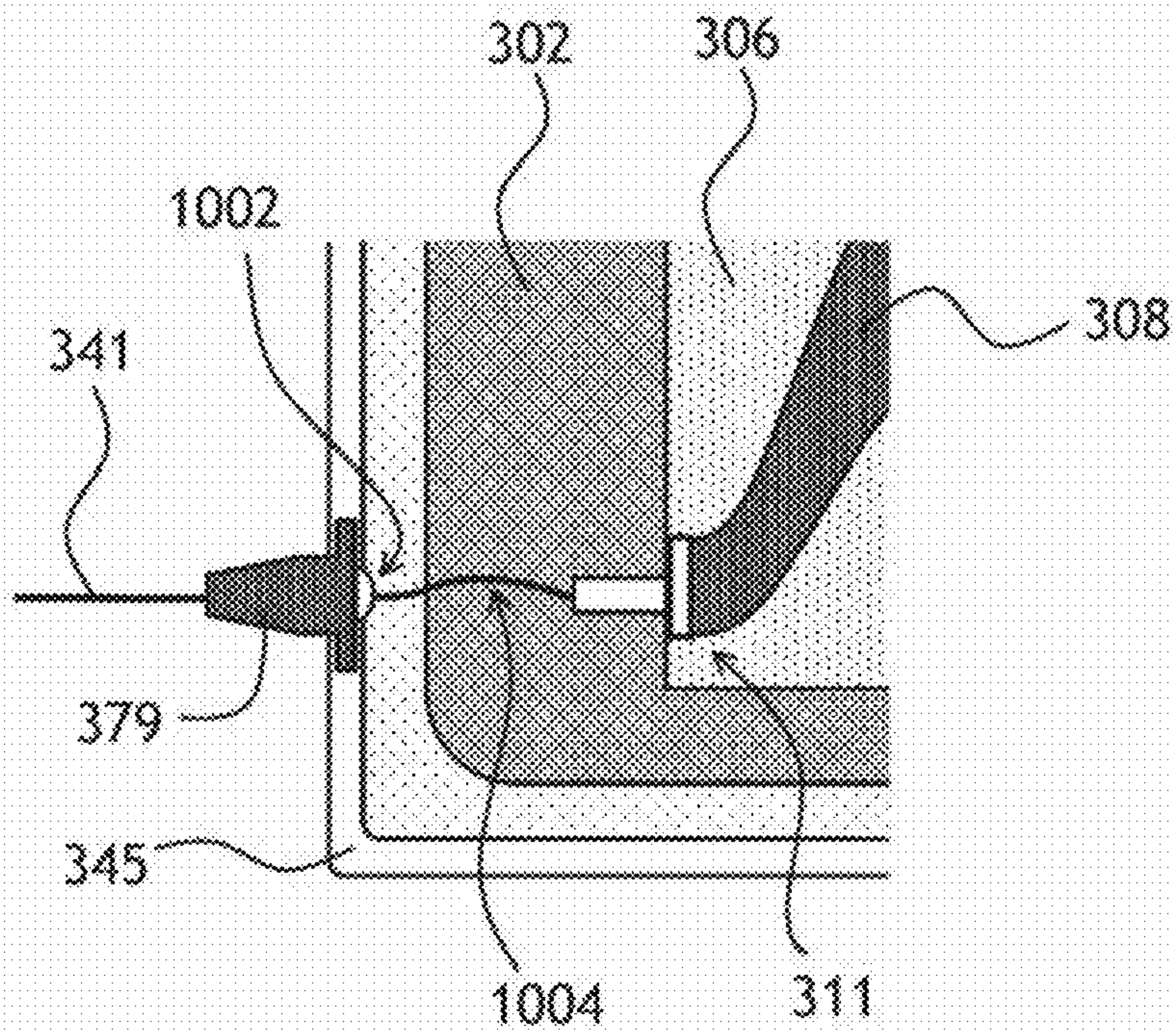


FIG. 10



## PACKAGING AN ARCUATE PLANAR LIGHTWAVE CIRCUIT

### CROSS-REFERENCE TO RELATED APPLICATIONS

This application is a continuation of U.S. application Ser. No. 14/226,578, filed Mar. 26, 2014 (now U.S. Pat. No. 9,213,138), which claims priority from U.S. Provisional Patent Application No. 61/805,415, filed Mar. 26, 2013, the disclosures of which are incorporated herein by reference.

### TECHNICAL FIELD

The present invention relates to optical components and modules, and in particular to packaging planar lightwave circuits of an arcuate shape.

### BACKGROUND OF THE INVENTION

Planar lightwave circuits (PLCs) are used to switch, attenuate, direct, modulate, separate, and combine light at different wavelengths. PLCs include waveguides and couplers formed in semiconductor wafers by photolithography. Advantages of large-scale manufacturability and compactness of PLCs are afforded by the methods borrowed from microelectronics and specifically developed for lightwave circuit applications.

One of most common examples of a PLC is an arrayed waveguide grating (AWG). AWGs are frequently used for wavelength separation and combination. An AWG includes an array of waveguides of incrementally increasing length between input and output slab couplers, to provide wavelength-dependent phase delay resulting in separation of light into individual wavelengths in the output slab coupler. Because the waveguides of the array have incremental lengths, an AWG typically has a bow-like, arcuate shape, with longer waveguides of the array disposed on the convex side of the AWG, and shorter waveguides of the array disposed on the concave side of the AWG.

To fit more bow-like waveguide structures on a single PLC wafer, it has been suggested to dispose individual AWG devices in a plane of the PLC wafer so that a convex side of one AWG borders a concave side of a next AWG. Referring to FIG. 1A, Watanabe et al. in US Patent Application Publication 2002/0113242 teach disposing individual AWGs **102** in two columns side by side on a PLC wafer **101**, so that individual AWG chips **107** can be cut out of the PLC wafer **101** by making straight cut lines **103A** and arcuate cut lines **103B**. The technology for making arcuate wafer cut lines is readily available, e.g. sandblasting or laser machining can be used to cut the PLC wafer **101** along the straight cut lines **103A** and arcuate cut lines **103B**.

Since wafer processing costs are dominant in PLC production, disposing more AWG chips **107** on the single wafer **101** results in significant economical benefits. Thus, arcuate AWG chips **107** are less expensive to produce than rectangular AWG chips, not shown. The arcuate AWG chips **107** are also easier to heat and keep at a constant temperature, due to reduced thermal mass of arcuate-cut AWG chips as compared to rectangular-cut AWG chips. Despite these advantages, the usage of the arcuate AWG chips **107** has been hitherto hindered by an increased sensitivity of the arcuate AWG chips **107** to mechanical stress. In particular, mechanical stress directed along a line connecting arcuate ends of the arcuate AWG chip **107** (ends of the bow) creates

a large optical path length variation in array waveguides of the AWGs **102**, due to a photoelastic effect in the waveguides.

To reduce the impact of the mechanical stress, the arcuate AWG chips **107** can be strengthened. Referring to FIG. 1B, Watanabe et al. attached reinforcement beams **151** and **152** to reinforce the arcuate AWG chip **107**, to make a reinforced AWG chip **107B**. Alternatively, turning to FIG. 1C, Watanabe et al. disclose that an arcuate-cut additional silicon substrate **171** can be attached to the arcuate AWG chip **107**, to make a compound arcuate AWG chip **107C**. The reinforced arcuate AWG chips **107B** and **107C** shown in FIGS. 1B and 1C, respectively, are less sensitive to mechanical stress. Detrimentally, attaching additional materials and layers to the arcuate AWG chip **107** is time-consuming and costly. The reinforcing elements have to be matched in their thermal expansion to the AWG chip **107**, to prevent bending of the AWG chip **107** out of its plane upon heating or cooling. Furthermore, the reinforced arcuate AWG chips **107B** and **107C** of FIGS. 1B and 1C, respectively, have a larger mass and thus have a larger thermal inertia, increasing a response time of a temperature stabilization loop.

The effect of optical path length variation due to squeezing or pushing the ends of arcuate AWG is so pronounced that attempts have been made to use this very effect for passive athermalization of AWG chips. For example, Ho et al. in US Patent Application Publication 2008/0080806 disclose an athermalized AWG having a stabilizing post or brace attached to ends of an arcuate AWG chip. The length of the post or brace changes with temperature, creating a temperature-dependent stress on the arcuate AWG chip, which counteracts thermal drift of the arcuate AWG chip. Similar ideas have also been disclosed in Chinese patent applications CN102354028A, CN101840030B, and CN100501468C.

One advantage of passive athermalization is that the temperature stabilization of the AWG chip is not required. Detrimentally however, passively athermalized AWG chips are more difficult to calibrate. Since every AWG has its own thermal drift magnitude, the length of the stabilizing post has to be individually adjusted for each AWG device manufactured, which is time-consuming, tedious, and impeding mass production.

### SUMMARY OF THE INVENTION

It is a goal of the invention to provide a simple mechanical packaging structure for an arcuate PLC chip, to lessen a mechanical stress applied to the chip. The inventors have discovered that the most stress is applied when optical fibers connecting to an arcuate PLC chip are pulled upon. In particular, when an output fiber array is pulled, the resulting mechanical stress causes larger wavelength shift than when a single input fiber is pulled. Furthermore, the inventors have discovered that an arcuate-cut PLC chip is so sensitive to mechanical stress that even using grummetts to hold a PLC chip-heater assembly in a package, without pulling on any fiber, can cause a severe wavelength shift when the grummetts are tightened.

To address stress-related wavelength shift issues, an arcuate PLC chip was epoxied to a heater plate with a soft adhesive. More sensitive multi-fiber end of the PLC chip was also attached to the heater plate with a hard adhesive. The heater plate was then attached to a base with a thick, soft adhesive tape. When the fiber was pulled upon, the stress was absorbed in the tape, the hard adhesive firmly holding the multi-waveguide end of the arcuate PLC chip and the



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heater together. Surprisingly, this simple structure has resulted in a dramatic reduction of stress-induced wavelength shifts, while allowing easy and efficient temperature stabilization of the entire arcuate-cut PLC chip. The stress-relieving effect was achieved without having to reinforce the arcuate-cut PLC chip with any ribs, arcuate supports, or the like, simplifying overall construction.

In accordance with the invention, there is provided a PLC module comprising:

- a base plate;
- a support layer on the base plate, the support layer having a thickness greater than 1 mm and a hardness of less than 40 Shore A;
- a heater plate on the support layer; and
- a planar lightwave circuit having a shape of an arcuate slab having an input port at its first end and a plurality of output ports at its second, opposed end. The planar lightwave circuit is adhered to the heater over an area spanning between the first and second ends with a first adhesive having a hardness less than 85 Shore A, and proximate the second end with a second adhesive having a hardness of greater than 70 Shore D.

In accordance with the invention, there is further provided an arrayed waveguide grating module comprising:

- a base plate;
- an adhesive tape having a thickness greater than 1 mm and a hardness less than 40 Shore A, adhered to the base plate;
- a ceramic heater plate adhered to the adhesive tape; and
- an arcuate arrayed waveguide chip having an input portion including an input waveguide, an output portion including a plurality of output waveguides, and a central portion therebetween having opposed concave and convex perimeter walls. The input, central, and output portions of the arcuate arrayed waveguide chip are affixed to the ceramic heater plate with a contiguous adhesive layer having a hardness less than 85 Shore A. The output portion of the arcuate arrayed waveguide chip is affixed to the ceramic heater plate with an adhesive having a hardness of at least 70 Shore D.

In accordance with another aspect of the invention, there is further provided a wavelength demultiplexor for demultiplexing a light signal into individual wavelengths, comprising:

- the arrayed waveguide grating module as described above;
- an input port coupled to the input waveguide;
- a plurality of output ports each coupled to a particular one of the plurality of output waveguides; and
- an encasing having the arrayed waveguide grating module affixed therein.

In accordance with yet another aspect of the invention, there is further provided a method of packaging a planar lightwave circuit, the method comprising:

- (a) providing a base plate;
- (b) affixing to the base plate a support layer having a thickness greater than 1 mm and a hardness of less than 40 Shore A;
- (c) providing a ceramic heater plate;
- (d) affixing the ceramic heater plate to the support layer;
- (e) epoxying to the ceramic heater plate a planar lightwave circuit having a shape of an arcuate slab having an input waveguide at its first end, a plurality of output waveguides at its second, opposed end, over an area spanning between the first and second ends with a first epoxy having a hardness less than 85 Shore A; and

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- (f) epoxying the second end of the planar lightwave circuit to the ceramic heater plate with a second epoxy having a hardness of greater than 70 Shore D.

#### BRIEF DESCRIPTION OF THE DRAWINGS

Exemplary embodiments will now be described in conjunction with the drawings, in which:

FIG. 1A is a plan view of a prior-art PLC wafer having two columns of stacked arcuate AWG structures separated by straight and arcuate cut lines;

FIG. 1B is a plan view of a prior-art arcuate AWG chip reinforced with a pair of symmetrically disposed straight beams;

FIG. 1C is an exploded isometric view of a prior-art arcuate AWG chip reinforced with an arcuate silicon substrate;

FIGS. 2A and 2B are elevational and plan views, respectively, of a PLC module of the invention;

FIG. 3 is an exploded isometric view of a wavelength demultiplexor module of the invention including the PLC module of FIGS. 2A and 2B;

FIG. 4 is a plan-view schematic diagram of arcuate AWG chips of the invention, usable in the PLC module of FIGS. 2A and 2B and in the wavelength demultiplexor of FIG. 3;

FIG. 5 is a spectral plot of a bandpass of a bottom arcuate chip of FIG. 4 mounted according to FIGS. 2A and 2B and FIG. 3, at various externally induced mechanical stress levels;

FIG. 6 is a spectral plot of a bandpass of the bottom arcuate chip of FIG. 4 mounted on a heater held by grumets, at the mechanical stress levels of FIG. 5;

FIG. 7 is a graph showing a wavelength shift due to externally induced mechanical stress for six wavelength demultiplexor module prototypes;

FIG. 8 is a simulated temperature distribution of the bottom arcuate AWG chip of FIG. 4;

FIG. 9 is a flow chart of manufacturing the PLC module of FIGS. 2A and 2B; and

FIG. 10 is a partial plan view of an input fiber portion of the wavelength demultiplexor module of FIG. 3.

#### DETAILED DESCRIPTION OF THE INVENTION

While the present teachings are described in conjunction with various embodiments and examples, it is not intended that the present teachings be limited to such embodiments. On the contrary, the present teachings encompass various alternatives and equivalents, as will be appreciated by those of skill in the art.

Referring to FIGS. 2A and 2B, a PLC module 200 includes a base plate 202 and a support layer 204 mounted on the base plate 202, a heater plate 206 mounted on the support layer 204, and a PLC 208 having a shape of an arcuate slab best seen in FIG. 2B. The PLC 208 has an input port 209 at its first end 211 and a plurality of output ports 210 at its second, opposed end 212. An input optical fiber 231 (FIG. 2B) can be optically and mechanically coupled to the input port 209 by placing the optical fiber 231 into a ferrule 234, and mechanically connecting the ferrule 234 to an input glass block 235, which is attached e.g. epoxied to the PLC 208 near its first end 211. Similarly, an output optical fiber array 233 can be optically and mechanically coupled to the plurality of output ports 210 by attaching a V-groove block 236 to an output glass block 237, which can be epoxied to the PLC 208 proximate its second end 212.



According to the invention, the support layer **204** has a thickness greater than 1 mm and a hardness less than 40 Shore A. The PLC **208** is adhered to the heater plate **206** over an area **214** spanning between the first **211** and second **212** ends with a first adhesive e.g. epoxy **221** having a hardness less than 85 Shore A. The PLC **208** is adhered to the heater plate **206** proximate the second end **212** with a second adhesive e.g. epoxy **222** having a hardness of greater than 70 Shore D. The second adhesive **222** has a much higher hardness than the first adhesive **221**. As a result, any pull stress applied to the output ports **210** at the second end **212** will be transferred to the heater plate **206** without exerting a considerable stress on the PLC **208**.

Furthermore, the mechanical stress applied to the second end **212** and transferred to the heater plate **206**, will be absorbed by thick and relatively soft support layer **204**. The stress transfer facilitates a considerable reduction of stress-induced wavelength shifts. The support layer **204** also serves as a heat insulator, facilitating uniform heating of the arcuate PLC **208**.

In a preferred embodiment, the PLC **208** includes an AWG chip, although other chips e.g. splitters, combiners, switches, etc. can be packaged in this way. When a multi-wavelength optical signal **230** is applied to the input optical fiber **231** coupled to the input port **209**, the PLC (AWG chip) **208** separates the multi-wavelength optical signal **230** into individual wavelengths **232**. The individual wavelengths **232** are output via the respective output ports **210** to individual optical fibers of a fiber array **233**. Of course, the notion of “input” and “output” ports of the PLC **208** is merely for convenience, and light can propagate backwards from “output” ports to “input” port(s).

The PLC **208** preferably has a length *L* between its first **211** and second **212** ends of 50 mm or less, and a width *W* of 20 mm or less. The thickness of the PLC **208** is preferably at least 0.4 mm.

To facilitate redirection of the mechanical stress away from the PLC **208**, the support layer **204** can include a thick and soft plastic or foam material, conveniently a thick and soft double-sided adhesive tape, or a non-adhesive tape or foam sheet coated with a suitable adhesive in a separate manufacturing step. Preferably, the thickness of the support layer **204** is between 1 mm and 4 mm, and more preferably between 1.5 and 2.5 mm. Using the soft first adhesive layer **221**, with hardness less than 85 Shore A, absorbs mechanical stress due to a mismatch between the thermal expansion coefficients (TEC) of the PLC **208** and the TEC of the heater plate **206**, enabling the use of inexpensive alumina ceramic heater plates. Preferably, the ceramic heater plate **206** includes a resistive heater encapsulated by alumina ceramic material on all sides. Other heaters/heat spreaders can also be used, even non-ceramic, with TEC of less than approximately 15 ppm/° C., and more preferably less than 7 ppm/° C., for PLC **208** made of silicon.

Conveniently, the base plate **202** can include a printed circuit board (PCB) having first **241** and second **242** electrical traces. The heater plate **206** can have first **251** and second **252** contacts, coupled to the first and second electrical traces, respectively, for providing a heating electric current.

Referring now to FIG. 3, a wavelength demultiplexor module **380** includes an AWG module **300** packaged into an encasing **350**. The AWG module **300** is similar to the PLC module **200** of FIGS. 2A and 2B. The AWG module **300** of FIG. 3 includes a base plate **302**, an adhesive tape **304** adhered to the base plate **302**, a ceramic heater plate **306** adhered to the adhesive tape **304**, and an arcuate AWG chip

**308** having an input portion **311** including an input waveguide **309**, an output portion **312** including a plurality of output waveguides **310**, and a central portion **313** between the input **311** and output **312** portions. The central portion **313** has opposed concave **314** and convex **315** perimeter walls. The input **311**, central **313**, and output **312** portions of the arcuate AWG chip **308** are affixed to the ceramic heater plate **306** with a contiguous soft adhesive layer **321** having a hardness of less than 85 Shore A. The output portion **312** of the arcuate AWG chip **308** is additionally affixed to the ceramic heater plate **306** with a hard adhesive layer **322** having a hardness of at least 70 Shore D. The adhesive tape **304** has a thickness greater than 1 mm and a hardness less than 40 Shore A.

In the embodiment shown in FIG. 3, the central portion **313** of the arcuate AWG chip **308** has an array of waveguides **316** running substantially parallel to each other between the convex **315** and concave **314** walls and throughout the central portion **313**. To save valuable wafer space, the central portion **313** can have a width of 20 mm or less, measured in a direction substantially perpendicular to the array of waveguides **316**. For convenience of assembly, the adhesive tape **304** can include first **391** and second **392** separate portions disposed under the input **311** and output **312** portions, respectively, of the arcuate AWG chip **308**. Similarly to the heater plate **206** of the PLC module **200** of FIGS. 2A and 2B, the heater plate **306** of the AWG module **300** of FIG. 3 can include a resistive element (not show) encapsulated by alumina ceramic. In the embodiment shown, the base plate **302** includes a printed circuit board.

The wavelength demultiplexor module **380** of FIG. 3 further includes an input port **341** optically coupled to the input waveguide **309** via an input fiber **331** held by a boot **379**, a plurality of output ports **342** each coupled to a particular one of the plurality of output waveguides **310** via a fiber ribbon **378**. The encasing **350** has the AWG module **308** affixed therein via screws **343** running through the base plate **302**. A lid **344** of the encasing **350** is attached to a bottom portion **345** of the encasing **350** by screws **346**. Of course, other encasings can be used.

Referring to FIG. 4, “wide” and “slim” arcuate AWG chips **408A** and **408B**, respectively, are usable in the AWG module **300** of FIG. 3 and in the PLC module **200** of FIGS. 2A and 2B. The “wide” arcuate AWG chip **408A** accommodates a 40-channel AWG structure (not shown). The width of the “wide” arcuate AWG chip **408A** is 11.19 mm at a beginning of an arcuate portion **414A**, and 20 mm at bases **415A**. The height of the “wide” arcuate AWG chip **408A** is 34.3 mm. The surface area of the “wide” arcuate AWG chip **408A** is 998.8 mm<sup>2</sup>.

The “slim” arcuate AWG chip **408B** accommodates a 48-channel AWG structure (not shown). The width of the “slim” arcuate AWG chip **408B** is only 6.29 mm at beginning of an arcuate portion **414B**, and 11.7 mm at bases **415B**. The height of the “slim” arcuate AWG chip **408B** is 35.75 mm. The surface area of the “slim” arcuate AWG chip **408B** is 587.4 mm<sup>2</sup>. The length of both the “wide” arcuate AWG chip **408A** and the “slim” arcuate AWG chip **408B** is 49.94 mm. Both the “wide” **408A** and “slim” **408B** arcuate AWG chips have been packaged into PLC modules of FIGS. 2A and 2B and have shown excellent wavelength stability w.r.t. mechanical stress. The “slim” arcuate AWG chip **408B** is preferable over the “wide” arcuate AWG chip **408A**, because the “slim” arcuate AWG chip **408B** has a smaller surface area than the “wide” arcuate AWG chip **408A**, and thus is less expensive to produce and quicker to heat.



Turning to FIG. 5 with further reference to FIG. 4, the position of a spectral band 500 of the “slim” arcuate AWG chip 408B is stable to within 1 pm at the mechanical stress applied according to Telcordia GR-1209 test protocol. By comparison, when the “slim” arcuate AWG chip 408B was mounted via grommets holding the heater plate 206 (FIGS. 2A and 2B), and the “slim” arcuate AWG chip 408B was epoxied to the heater plate 206 with an epoxy having a hardness of Shore 85 A, the stress-induced center wavelength variation was well over 40 pm. For instance, referring to FIG. 6, spectra 601 to 608 have the center wavelength varied by approximately 60 pm under the above test protocol conditions.

Turning now to FIG. 7, six prototypes of the “slim” arcuate AWG chip 408B “1”, “2”, “3”, “4”, “5”, and “6”, mounted as shown in FIGS. 2A and 2B, have been tested for stress-induced wavelength shift. The stress was applied according to Telcordia GR-1209, GR-1312 and GR-63 test protocols. One can see that the stress due to cable pull 711, package drop 712, shock 713, and vibration 714 was within  $\pm 10$  pm, which is much better than spec limits 701, 702 of  $\pm 30$  pm.

Temperature distribution, of the heater plate 206 of FIG. 2A has been simulated. Referring to FIG. 8, the maximum temperature variation of the “slim” arcuate AWG chip 408B on the heater plate 206, represented by shades of gray, was within  $0.11^\circ$  C., which corresponds to the wavelength shift of 2 pm. The heater plate 206 was made of alumina ceramic.

Referring now to FIG. 9 with further reference to FIG. 3, a method 900 of manufacturing a PLC module e.g. the AWG module 300 of FIG. 3 includes a step 901 (FIG. 9) of providing the base 302. In a step 902, the support layer 304 is affixed to the base 302. The support layer 304 has a thickness greater than 1 mm and a hardness of less than 40 Shore A. In a step 903, the ceramic heater plate 306 is provided. Then, in a step 904, the ceramic heater plate 306 is affixed to the support layer 304. The support layer 304 can include the strips 391 and 392 of a thick, soft adhesive tape.

In a following step 905, the arcuate AWG 308 is epoxied to the heater plate 306 over an area spanning between the first and second ends with the soft epoxy layer 321 having a hardness less than 85 Shore A. The soft epoxy allows for some stress relaxation due to thermal mismatch between the heater plate 306 and the arcuate AWG 308. After the soft epoxy layer was applied, the soft epoxy layer 321 is cured e.g. for two hours at an elevated temperature of  $110^\circ$  C.

In a step 906, the second end of the arcuate AWG 308 is epoxied to the ceramic heater plate 306 with a hard epoxy 322 having a hardness of greater than 70 Shore D. This step is preferably performed after the assembly is removed from the oven after the soft epoxying step 905, to avoid shifts or turns of the arcuate AWG 308 upon local application and curing the hard epoxy.

Referring now to FIG. 10 with further reference to FIGS. 3 and 9, the assembled AWG module 300 and the fiber boot 379 can be placed into the bottom portion 345 of the encasing 350 in a step 907. The input fiber 341 is then affixed to the fiber boot 379 with a soft epoxy or silicon rubber 1002. The length of the input fiber 341 between the fiber boot 379 and the arcuate AWG chip 308 is selected so that when the AWG module 300 is placed into the bottom portion 345 of the encasing 350 and the soft epoxy or silicon rubber 1002 is applied to fix the input fiber 341, the latter has a slight bend 1004, e.g. with a bend radius of less than 50 cm. The bend 1004 is provided for stress relieving purposes, and/or to provide a room for mechanical tolerances. Of

course, not only the arcuate AWG 308, but other types of arcuate PLC can be packaged using the method 900 of FIG. 9.

The foregoing description of one or more embodiments of the invention has been presented for the purposes of illustration and description. It is not intended to be exhaustive or to limit the invention to the precise form disclosed. Many modifications and variations are possible in light of the above teaching. It is intended that the scope of the invention be limited not by this detailed description, but rather by the claims appended hereto.

What is claimed is:

1. An optical module comprising:

- a base plate;
- a support layer located on the base plate, wherein the support layer has a hardness less than a first particular Shore A value;
- a heater plate located on the support layer; and
- a chip having an input at a first end and a plurality of outputs at a second end, wherein the chip is adhered to the heater plate, across an area spanning the first end and the second end, with a first adhesive having a hardness less than a second particular Shore A value, wherein the second particular Shore A value is greater than the first particular Shore A value, and wherein the chip is adhered to the heater plate proximate the second end with a second adhesive having a hardness greater than a particular Shore D value, wherein the particular Shore D value is greater than the second particular Shore A value.

2. The optical module of claim 1, wherein the base plate includes a first electrical trace and a second electrical trace, the first electrical trace is coupled to a first contact of the heater plate, and the second electrical trace is coupled to a second contact of the heater plate.

3. The optical module of claim 1, wherein the chip is shaped as an arcuate slab.

4. The optical module of claim 1, wherein the chip is a planar lightwave circuit (PLC).

5. The optical module of claim 1, wherein the chip is an arrayed waveguide grating (AWG).

6. The optical module of claim 5, wherein the AWG is adhered to the base plate at a first portion and a second portion.

7. The optical module of claim 6, wherein a hardness of the first portion is less than the first particular Shore A value, and a hardness of the second portion is less than the first particular Shore A value.

8. An optical module comprising:

- a base plate;
- a support layer located on the base plate, wherein the support layer has a hardness less than a first value;
- a heater plate located on the support layer; and
- a chip having an input at a first end and a plurality of outputs at a second end, wherein the chip is adhered to the heater plate, across an area spanning the first end and the second end, with a first adhesive having a hardness less than a second value, wherein the second value is greater than the first value, and



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wherein the chip is adhered to the heater plate proximate the second end with a second adhesive having a hardness greater than a third value, wherein the third value is greater than the second value.

9. The optical module of claim 8, wherein the base plate includes a first electrical trace and a second electrical trace, the first electrical trace is coupled to a first contact of the heater plate, and the second electrical trace is coupled to a second contact of the heater plate.

10. The optical module of claim 8, wherein the chip is shaped as an arcuate slab.

11. The optical module of claim 8, wherein the chip is a planar lightwave circuit (PLC).

12. The optical module of claim 8, wherein the chip is an arrayed waveguide grating (AWG).

13. The optical module of claim 12, wherein the AWG is adhered to the base plate at a first portion and a second portion.

14. The optical module of claim 13, wherein a hardness of the first portion is less than the first value, and a hardness of the second portion is less than the first value.

15. A method comprising:  
affixing a base plate and a support layer together, wherein the support layer has a hardness less than a first value;  
affixing a heater plate and the support layer together;  
epoxying the heater plate and a chip together, wherein the chip has input at a first end and a plurality of outputs at a second end, and

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wherein the chip and the heater plate are epoxyed across an area, spanning the first end and the second end, with a first epoxy having a hardness less than a second value,

wherein the second value is greater than the first value; and

epoxying the heater plate and the second end of the chip together with a second epoxy having a hardness greater than a third value,

wherein the third value is greater than the second value.

16. The method of claim 15, wherein the base plate includes a first electrical trace and a second electrical trace, and

the method further includes:

coupling the first electrical trace to a first contact of the heater plate, and

coupling the second electrical trace to a second contact of the heater plate.

17. The method of claim 15, wherein the chip is shaped as an arcuate slab.

18. The method of claim 15, wherein the chip is a planar lightwave circuit (PLC).

19. The method of claim 15, wherein the chip is an arrayed waveguide grating (AWG).

20. The method of claim 19, wherein

the AWG is adhered to the base plate at a first portion and a second portion,

a hardness of the first portion is less than the first value, and

a hardness of the second portion is less than the first value.

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